MSKSEMI 美森科







TSS



MOV



GDT



PIFF

FDMC7696-MS

Product specification





Description

The FDMC7696-MS uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

Features

- V_{DS} = 30V I_D = 30A
- $R_{DS(ON)} < 13m\Omega$ @ $V_{GS} = 10V$

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

DFN3X3-8L	N-Channel MOSFET	Marking
S S S S S S S S S S S S S S S S S S S	G	MSKSEMI C7696 N30

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
lo@Tc=25℃	Continuous Drain Current, V _{GS} @ 10V¹	30	Α
lo@Tc=100℃	Continuous Drain Current, V _{GS} @ 10V ¹	18	А
IDM	Pulsed Drain Current ²	55	Α
EAS	Single Pulse Avalanche Energy ³	22.1	mJ
IAS	Avalanche Current	21	Α
P @Tc=25℃	Total Power Dissipation ⁴	20	W
TSTG	Storage Temperature Range	-55 to 150	\mathbb{C}
TJ	Operating Junction Temperature Range	-55 to 150	\mathbb{C}
R₀JA	Thermal Resistance Junction-ambient ¹	75	°C/W
R₀JC	Thermal Resistance Junction-Case ¹	6	°C/W



Electrical Characteristics (TJ=25 °C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	30			V
△BVɒss/△Tɹ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.022		V/°C
	Static Drain-Source On-Resistance ²	Vgs=10V , ID=10A		8	13	
Rds(on)		Vgs=4.5V , ID=5A		12	20	mΩ
V _{GS} (th)	Gate Threshold Voltage	V V 1 050 A	1.0		2.5	V
$\triangle V$ GS(th)	V _{GS(th)} Temperature Coefficient	Vgs=Vbs , Ib =250uA		-5.1		mV/°C
la a a		VDS=24V , VGS=0V , TJ=25°C			1	
loss	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
Igss	Gate-Source Leakage Current	V _G s=±20V , V _D s=0V			± 100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =1A		4.5		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.5		Ω
Qg	Total Gate Charge (4.5V)	Vps=20V , Vgs=4.5V , Ip=10A		7.2		
Qgs	Gate-Source Charge			1.4		nC
\mathbf{Q}_{gd}	Gate-Drain Charge			2.2		
Td(on)	Turn-On Delay Time	\/10\/ \/10\/		4.1		
Tr	Rise Time	Vpp=12V , Vgs=10V , Rg=3.3		9.8		ne
Td(off)	Turn-Off Delay Time	b=5A		15.5		ns
Tf	Fall Time	ID=5A		6.0		
Ciss	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		572		
Coss	Output Capacitance			81		pF
Crss	Reverse Transfer Capacitance			65		
ls	Continuous Source Current ^{1,5}	V V 2V 5 2 :			28	Α
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			55	Α
Vsb	Diode Forward Voltage ²	V _G s=0V , I _S =1A , T _J =25°C			1.2	V

Note:

- 1.The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=21A
- 4 .The power dissipation is limited by $150\,^\circ\mathrm{C}$ junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.



Typical Characteristics

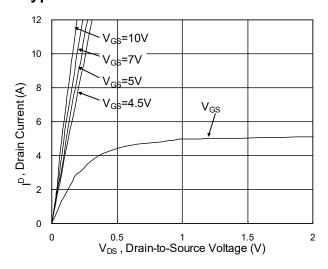


Fig.1 Typical Output Characteristics

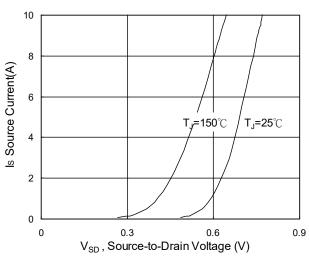


Fig.3 Forward Characteristics Of Reverse

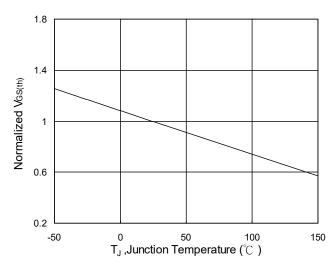


Fig.5 Normalized V_{GS(th)} vs. T_J

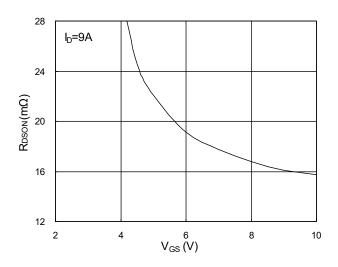


Fig.2 On-Resistance vs. Gate-Source

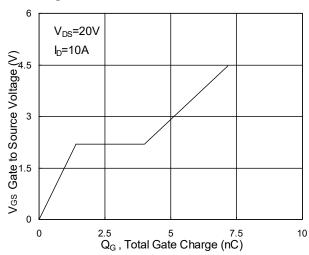


Fig.4 Gate-Charge Characteristics

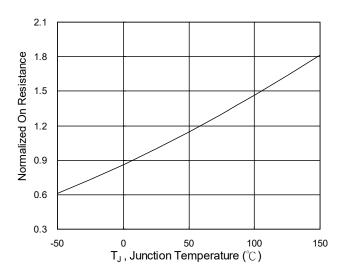
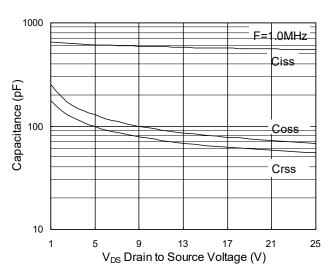


Fig.6 Normalized $R_{\text{DSON}}\,\text{vs}\ T_{\text{J}}$





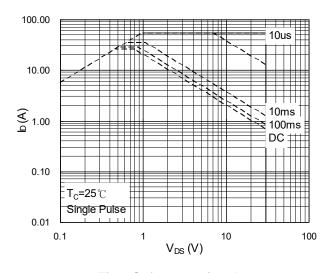


Fig.7 Capacitance

Fig.8 Safe Operating Area

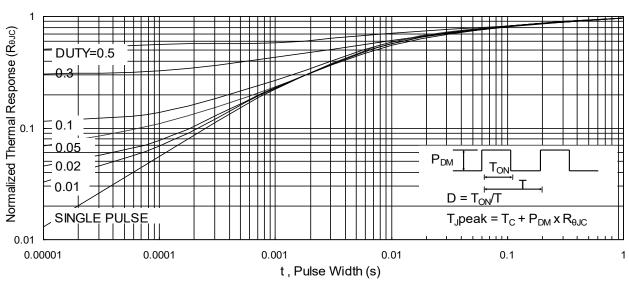


Fig.9 Normalized Maximum Transient Thermal Impedance

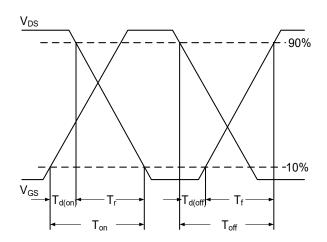


Fig.10 Switching Time Waveform

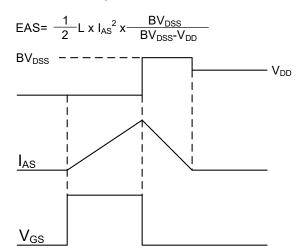
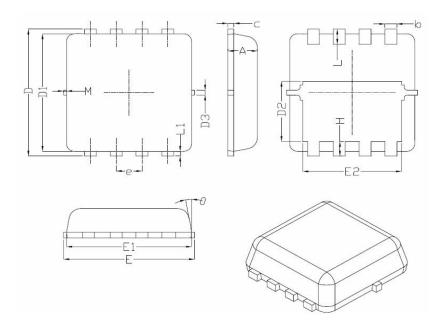


Fig.11 Unclamped Inductive Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters		
	Min.	Nom.	Max.
A	0.70	0.75	0.80
b	0.25	0.30	0.35
С	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.48	1.58	1.68
D3	-	0.13	-
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
е	0.65BSC		
Н	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	-	0.13	-
M	*	*	0.15
θ		10 [°]	12 [°]

REEL SPECIFICATION

P/N	PKG	QTY
FDMC7696-MS	DFN3X3-8L	5000



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